ON Semiconductor

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MOSFET - Power, N-Channel, SUPERFET® III, FAST

650 V, 165 mΩ, 19 A

NTP165N65S3H

Description

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provides superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET FAST series helps minimize various power systems and improve system efficiency.

Features

- $700 \text{ V} @ \text{T}_{\text{J}} = 150^{\circ}\text{C}$
- Typ. $R_{DS(on)} = 132 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q_g = 35 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 326 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

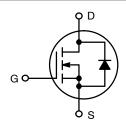
- Telecom / Server Power Supplies
- Industrial Power Supplies
- UPS / Solar

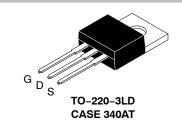


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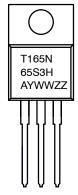
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V _{DSS}	R _{DS(ON)} MAX	I _D MAX
650 V	165 mΩ @ 10 V	19 A





MARKING DIAGRAM



T165N65S3H = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise specified)

Symbol	Parameter		Value	Unit	
V _{DSS}	Drain to Source Voltage		650	V	
V_{GSS}	Gate to Source Voltage	DC	±30	V	
		AC (f > 1 Hz)	±30	V	
I _D	Drain Current	Continuous (T _C = 25°C)	19	Α	
		Continuous (T _C = 100°C)	12		
I _{DM}	Drain Current	Pulsed (Note 1)	53	Α	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		163	mJ	
I _{AS}	Avalanche Current (Note 2)		4	Α	
E _{AR}	Repetitive Avalanche Energy (Note 1)		1.42	mJ	
dv/dt	MOSFET dv/dt		120	V/ns	
	Peak Diode Recovery dv/dt (Note 3)		20	1	
P_{D}	Power Dissipation	(T _C = 25°C)	142	W	
		Derate Above 25°C	1.14	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		−55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 s		260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. $I_{AS} = 4$ A, $R_{G} = 25$ Ω , starting $T_{J} = 25^{\circ}C$. 3. $I_{SD} \le 9.5$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le 400$ V, starting $T_{J} = 25^{\circ}C$.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.88	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Shipping
NTP165N65S3H	T165N65S3H	TO-220-3LD (Pb-Free / Halogen Free)	50 Units / Tube

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS			•		
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	650			V
		V _{GS} = 0 V, I _D = 1 mA, T _J = 150°C	700			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, Referenced to 25°C		0.63		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0 V			1	μΑ
		$V_{DS} = 520 \text{ V}, T_{C} = 125^{\circ}\text{C}$		1.0		
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
N CHARACTE	ERISTICS		•		-	
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 1.6 \text{ mA}$	2.4		4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 9.5 A		132	165	mΩ
9FS	Forward Transconductance	V _{DS} = 20 V, I _D = 9.5 A		24		S
YNAMIC CHA	RACTERISTICS			•		
C _{iss}	Input Capacitance	V _{DS} = 400 V, V _{GS} = 0 V, f = 250 kHz		1808		pF
C _{oss}	Output Capacitance			27		pF
C _{oss(eff.)}	Effective Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V		326		pF
C _{oss(er.)}	Energy Related Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V		47		pF
Q _{g(tot)}	Total Gate Charge at 10 V			35		nC
Q _{gs}	Gate to Source Gate Charge	V _{DS} = 400 V, I _D = 9.5 A, V _{GS} = 10 V (Note 4)		8.4		nC
Q _{gd}	Gate to Drain "Miller" Charge	(1333-1)		9.2		nC
ESR	Equivalent Series Resistance	f = 1 MHz		1.1		Ω
WITCHING CH	HARACTERISTICS					
t _{d(on)}	Turn-On Delay Time			20		ns
t _r	Turn-On Rise Time	$V_{DD} = 400 \text{ V}, I_D = 9.5 \text{ A},$		8.5		ns
t _{d(off)}	Turn-Off Delay Time	$V_{DD} = 400 \text{ V}, I_D = 9.5 \text{ A}, \ V_{GS} = 10 \text{ V}, R_g = 10 \Omega \ (\text{Note 4})$		68		ns
t _f	Turn-Off Fall Time			3		ns
OURCE-DRAI	N DIODE CHARACTERISTICS		-		•	-
I _S	Maximum Continuous Source to Drain Diode Forward Current				19	Α
I _{SM}	Maximum Pulsed Source to Drain Diode Forward Current				53	Α
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 9.5 A			1.2	V
t _{rr}	Reverse Recovery Time	$V_{DD} = 400 \text{ V}, I_{SD} = 9.5 \text{ A},$ $dI_F/dt = 100 \text{ A/}\mu\text{s}$		264		ns
Q _{rr}	Reverse Recovery Charge			3.6		μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

TYPICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

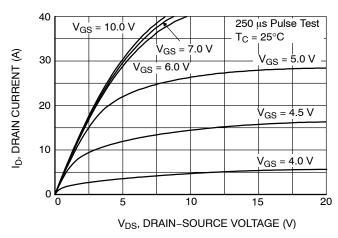


Figure 1. On-Region Characteristics

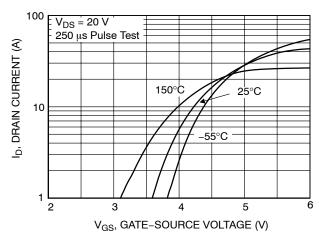


Figure 2. Transfer Characteristics

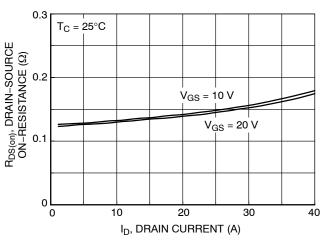


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

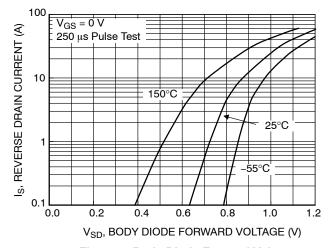


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

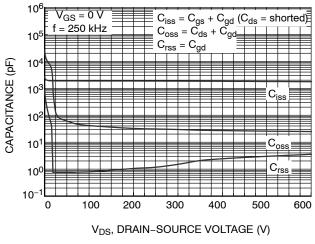


Figure 5. Capacitance Characteristics

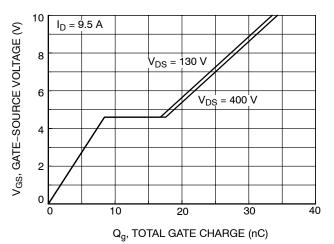


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted) (continued)

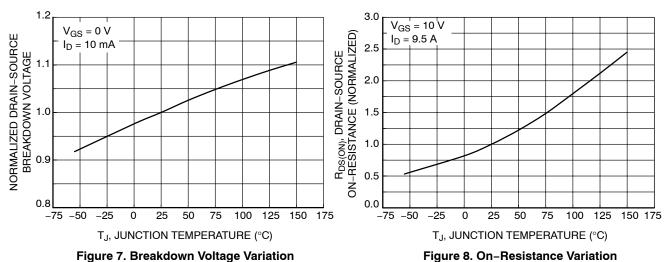


Figure 7. Breakdown Voltage Variation vs. Temperature

10 ແs

100 μs

1 ms

10 ms

100

10

0.1

Operation in this

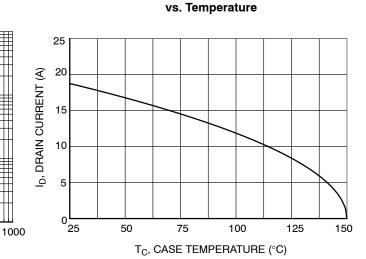
Area is Limited

by R_{DS(on)}

 $T_C = 25^{\circ}C$

T_J = 150°C Single Pulse

ID, DRAIN CURRENT (A)



 $\label{eq:VDS} V_{DS}, DRAIN-SOURCE VOLTAGE (V) $$ Figure 9. Maximum Safe Operating Area$

Figure 10. Maximum Drain Current vs. Case Temperature

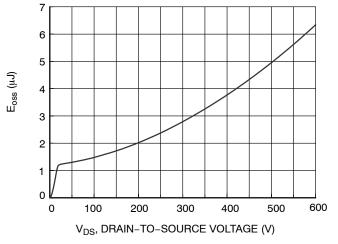


Figure 11. E_{OSS} vs. Drain to Source Voltage

TYPICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted) (continued)

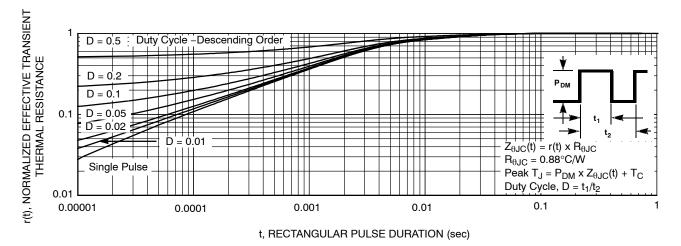


Figure 12. Transient Thermal Response Curve

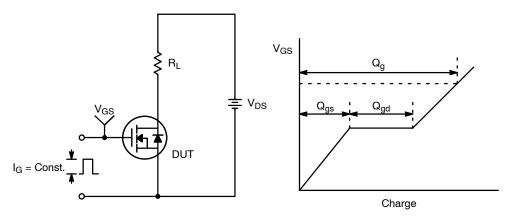


Figure 13. Gate Charge Test Circuit & Waveform

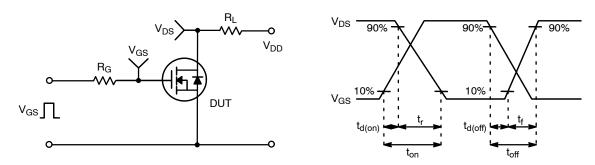


Figure 14. Resistive Switching Test Circuit & Waveforms

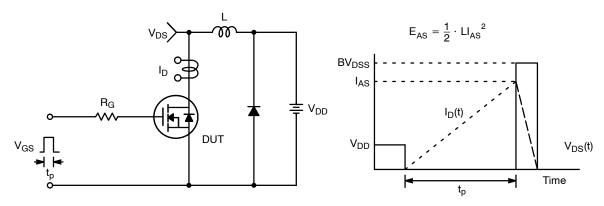


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

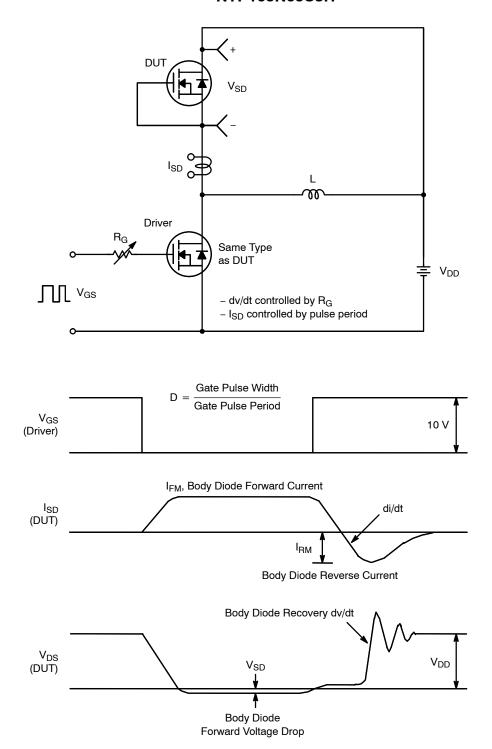
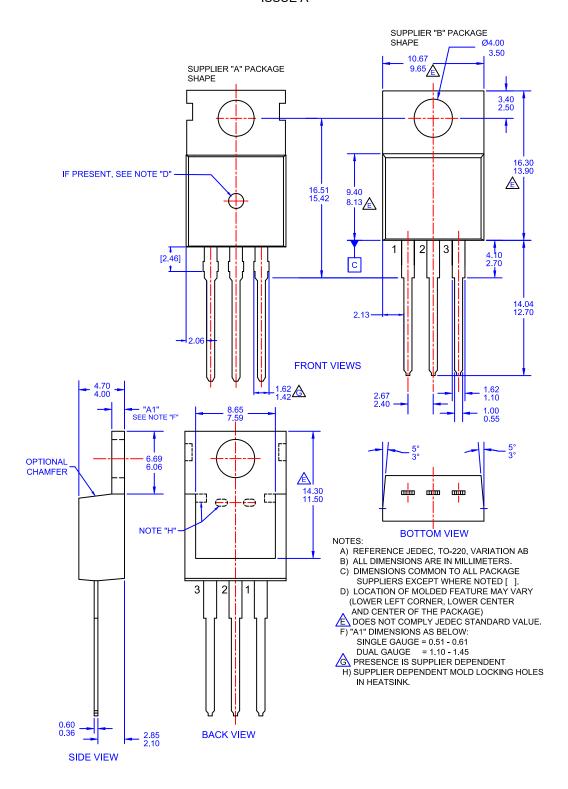


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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PACKAGE DIMENSIONS

TO-220-3LD CASE 340AT ISSUE A



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